



#### COMPLEMENTARY PAIR ENHANCEMENT MODE MOSFET

### **Product Summary**

Device	V <sub>(BR)DSS</sub>	R <sub>DS(ON)</sub> max	I <sub>D</sub> max T <sub>A</sub> = +25°C
Q1	30V	$25m\Omega$ @ $V_{GS}$ = $10V$	6.5A
Q1 30	307	29mΩ @ $V_{GS}$ = 4.5 $V$	6.1A
Q2	-30V	$28m\Omega$ @ $V_{GS}$ = -10V	-6.2A
Q2		$38m\Omega$ @ $V_{GS} = -4.5V$	-5.3A

### **Description**

This new generation MOSFET has been designed to minimize the onstate resistance ( $R_{DS(ON)}$ ) and yet maintain superior switching performance, making it ideal for high efficiency power management applications.

### **Applications**

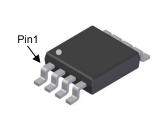
- DC-DC Converters
- Power Management Functions
- Backlighting

### **Features and Benefits**

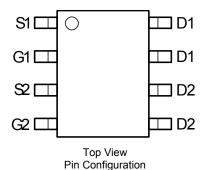
- Low Input Capacitance
- Low On-Resistance
- Fast Switching Speed
- Totally Lead-Free & Fully RoHS Compliant (Notes 1 & 2)
- Halogen and Antimony Free. "Green" Device (Note 3)
- Qualified to AEC-Q101 Standards for High Reliability

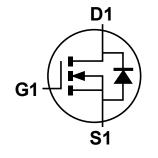
#### **Mechanical Data**

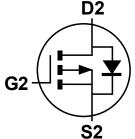
- Case: SO-8
- Case Material: Molded Plastic, "Green" Molding Compound.
   UL Flammability Classification Rating 94V-0
- Moisture Sensitivity: Level 1 per J-STD-020
- Terminal Connections: See Diagram
- Terminals: Finish Tin Finish annealed over Copper leadframe.
   Solderable per MIL-STD-202, Method 208 (3)
- Weight: 0.074 grams (approximate)











**Equivalent Circuit** 

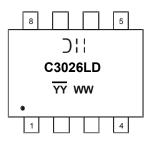
#### Ordering Information (Note 4)

Part Number	Case	Packaging		
DMC3026LSD-13	SO-8	2,500/Tape & Reel		

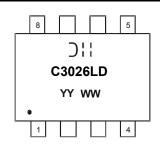
Notes:

- 1. No purposely added lead. Fully EU Directive 2002/95/EC (RoHS) & 2011/65/EU (RoHS 2) compliant.
- 2. See http://www.diodes.com/quality/lead\_free.html for more information about Diodes Incorporated's definitions of Halogen- and Antimony-free, "Green" and Lead-free
- 3. Halogen- and Antimony-free "Green" products are defined as those which contain <900ppm bromine, <900ppm chlorine (<1500ppm total Br + Cl) and <1000ppm antimony compounds.
- 4. For packaging details, go to our website at http://www.diodes.com/products/packages.html.

## **Marking Information**



Chengdu A/T Site



Shanghai A/T Site

);; = Manufacturer's Marking C3026LD = Product Type Marking Code YYWW = Date Code Marking YY or YY = Year (ex: 14 = 2014) WW = Week (01 - 53)

YY = Date Code Marking for SAT (Shanghai Assembly/ Test site)
YY = Date Code Marking for CAT (Chengdu Assembly/ Test site)



## Maximum Ratings - Q1 and Q2 (@T<sub>A</sub> = +25°C, unless otherwise specified.)

Characteristic	Symbol	Q1	Q2	Units		
Drain-Source Voltage	$V_{DSS}$	30	-30	V		
Gate-Source Voltage	$V_{GSS}$	±20	±20	V		
	Steady State	$T_A = +25^{\circ}C$ $T_A = +70^{\circ}C$	I <sub>D</sub>	6.5 5.2	-6.2 -5.0	А
Continuous Drain Current (Note 6) V <sub>GS</sub> = 10V	t<10s	T <sub>A</sub> = +25°C T <sub>A</sub> = +70°C	I <sub>D</sub>	8.2 6.7	-8.0 -6.5	А
Maximum Body Diode Forward Current (Note 6)	Is	2.2	-2.5	Α		
Pulsed Drain Current (10µs pulse, duty cycle = 1	I <sub>DM</sub>	40	-40	Α		
Avalanche Current (Notes 7) L = 0.1mH	I <sub>AS</sub>	14.5	22	Α		
Avalanche Energy (Notes 7) L = 0.1mH	E <sub>AS</sub>	10.5	25	mJ		

## Thermal Characteristics (@TA = +25°C, unless otherwise specified.)

Characteristic		Symbol	Value	Units
Total Power Dissipation (Note 5)	T <sub>A</sub> = +25°C	P <sub>D</sub>	1.2	W
Total Fower Dissipation (Note 5)	T <sub>A</sub> = +70°C		0.8	VV
Thermal Resistance, Junction to Ambient (Note 5)	Steady state	R <sub>0,JA</sub>	102	°C/W
Thermal Resistance, suriction to Ambient (Note 5)	t<10s	Көја	62	
Total Power Dissipation (Note 6)	T <sub>A</sub> = +25°C	PD	1.6	W
Total Fower Dissipation (Note o)	T <sub>A</sub> = +70°C	FD	1.0	
Thermal Resistance, Junction to Ambient (Note 6)	Steady state	Roja	78	°C/W
Thermal Resistance, Junction to Ambient (Note 0)	t<10s	К⊎ЈА	47	
Thermal Resistance, Junction to Case (Note 6)		Rojc	14.5	
Operating and Storage Temperature Range		T <sub>J,</sub> T <sub>STG</sub>	-55 to +150	°C

## Electrical Characteristics - Q1 (@T<sub>A</sub> = +25°C, unless otherwise specified.)

Characteristic	Symbol	Min	Тур	Max	Unit	Test Condition	
OFF CHARACTERISTICS (Note 8)							
Drain-Source Breakdown Voltage	$BV_{DSS}$	30	_	_	V	$V_{GS} = 0V, I_D = 250\mu A$	
Zero Gate Voltage Drain Current	I <sub>DSS</sub>	_	_	1	μA	V <sub>DS</sub> = 24V, V <sub>GS</sub> = 0V	
Gate-Source Leakage	I <sub>GSS</sub>	_	_	±100	nA	$V_{GS} = \pm 20V, V_{DS} = 0V$	
ON CHARACTERISTICS (Note 8)		•			•		
Gate Threshold Voltage	V <sub>GS(th)</sub>	1	_	3	V	$V_{DS} = V_{GS}$ , $I_D = 250\mu A$	
Static Drain-Source On-Resistance	D	_	19	25	m()	V <sub>GS</sub> = 10V, I <sub>D</sub> = 6A	
Static Drain-Source On-Resistance	R <sub>DS (ON)</sub>	_	22	29	mΩ	V <sub>GS</sub> = 4.5V, I <sub>D</sub> = 5A	
Diode Forward Voltage	V <sub>SD</sub>	_	0.7	1.2	V	V <sub>GS</sub> = 0V, I <sub>S</sub> = 1.3A	
DYNAMIC CHARACTERISTICS (Note 9)	•	•	•	•		•	
Input Capacitance	C <sub>iss</sub>	_	641	_		V <sub>DS</sub> = 15V, V <sub>GS</sub> = 0V f = 1.0MHz	
Output Capacitance	Coss	_	66	_	pF		
Reverse Transfer Capacitance	C <sub>rss</sub>	_	51	_			
Gate Resistance	$R_G$	_	2.2	_	Ω	$V_{DS} = 0V, V_{GS} = 0V, f = 1.0MHz$	
Total Gate Charge (V <sub>GS</sub> = 4.5V)	Qg	_	6	_			
Total Gate Charge (V <sub>GS</sub> = 10V)	Qg	_	13.2	_	nC	V <sub>DS</sub> = 15V, I <sub>D</sub> = 10A	
Gate-Source Charge	Qgs	_	1.7	_	IIC		
Gate-Drain Charge	Q <sub>gd</sub>	_	2.2	_			
Turn-On Delay Time	t <sub>D(on)</sub>	_	3.3	_		$V_{GS} = 10V, V_{DD} = 15V, R_G = 6\Omega,$	
Turn-On Rise Time	t <sub>r</sub>	_	4.4	_	nS		
Turn-Off Delay Time	t <sub>D(off)</sub>	_	22.3	_	110	I <sub>D</sub> = 1A	
Turn-Off Fall Time	t <sub>f</sub>	_	5.3	_			

Device mounted on FR-4 substrate PC board, 2oz copper, with minimum recommended pad layout.
 Device mounted on FR-4 substrate PC board, 2oz copper, with 1inch square copper plate.
 UIS in production with L = 0.1mH, starting T<sub>A</sub> = +25°C.
 Short duration pulse test used to minimize self-heating effect.

9. Guaranteed by design. Not subject to product testing.



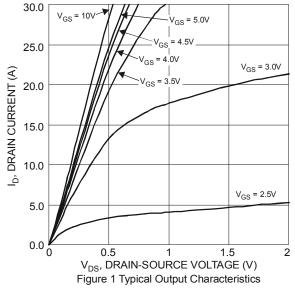
## Electrical Characteristics – Q2 (@T<sub>A</sub> = +25°C, unless otherwise specified.)

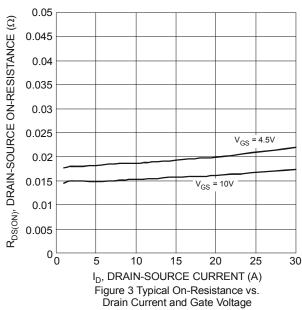
Characteristic	Symbol	Min	Тур	Max	Unit	Test Condition	
OFF CHARACTERISTICS (Note 8)							
Drain-Source Breakdown Voltage	$BV_{DSS}$	-30	_	_	V	$V_{GS} = 0V, I_D = -250\mu A$	
Zero Gate Voltage Drain Current	I <sub>DSS</sub>		_	-1	μA	V <sub>DS</sub> = -24V, V <sub>GS</sub> = 0V	
Gate-Source Leakage	I <sub>GSS</sub>		_	±100	nA	$V_{GS} = \pm 20V, V_{DS} = 0V$	
ON CHARACTERISTICS (Note 8)							
Gate Threshold Voltage	$V_{GS(th)}$	-1		-3	V	$V_{DS} = V_{GS}, I_{D} = -250 \mu A$	
Static Drain-Source On-Resistance	נ		21	28	m0	$V_{GS} = -10V, I_D = -6A$	
Static Dialii-Source Oil-Resistance	R <sub>DS(ON)</sub>		29	38	mΩ	$V_{GS} = -4.5V, I_D = -5A$	
Diode Forward Voltage	$V_{SD}$		-0.7	-1.2	V	$V = V_{GS} = 0V, I_S = -1.3A$	
DYNAMIC CHARACTERISTICS (Note 9)							
Input Capacitance	C <sub>iss</sub>		1241	_		V <sub>DS</sub> = -15V, V <sub>GS</sub> = 0V f = 1.0MHz	
Output Capacitance	Coss		146	_	pF		
Reverse Transfer Capacitance	C <sub>rss</sub>		110	_			
Gate Resistance	$R_G$		14.8	_	Ω	$V_{DS} = 0V, V_{GS} = 0V, f = 1.0MHz$	
Total Gate Charge (V <sub>GS</sub> = -4.5V)	$Q_g$		10.9	_		V <sub>DS</sub> = -15V, I <sub>D</sub> = -7A	
Total Gate Charge (V <sub>GS</sub> = -10V)	$Q_g$		22	_	nC		
Gate-Source Charge	$Q_{gs}$		3.5	_	IIC		
Gate-Drain Charge	$Q_{gd}$		4.7	_			
Turn-On Delay Time	t <sub>D(on)</sub>	_	9.7	_		$V_{GS} = -10V, V_{DD} = -15V, R_{GEN} = 6\Omega,$	
Turn-On Rise Time	t <sub>r</sub>	_	17.1	_	nS		
Turn-Off Delay Time	t <sub>D(off)</sub>	_	60.5	_	1110	I <sub>D</sub> = -7A	
Turn-Off Fall Time	t <sub>f</sub>	_	40.4	_	1		

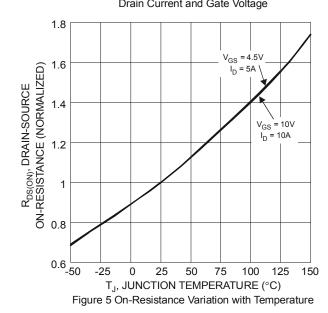
Notes:

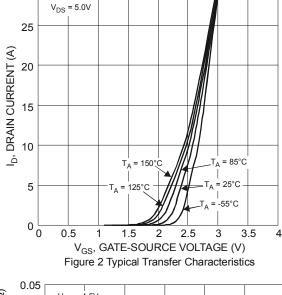
- Short duration pulse test used to minimize self-heating effect.
   Guaranteed by design. Not subject to product testing.



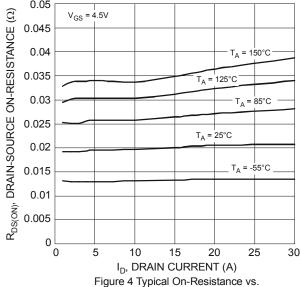








30



Drain Current and Temperature

0.04  $R_{DS(ON)}$ , DRAIN-SOURCE ON-RESISTANCE  $(\Omega)$ 0.035 V<sub>GS</sub> = 4.5V I<sub>D</sub> = 5A 0.03 0.025 V<sub>GS</sub> = 10V I<sub>D</sub> = 10A 0.02 0.015 0.01 0.005 0 <u></u>-50 -25 25 50 125 150 0 75 100 T<sub>J</sub>, JUNCTION TEMPERATURE (°C)



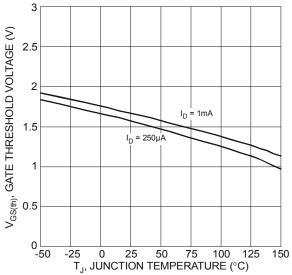


Figure 7 Gate Threshold Variation vs. Ambient Temperature

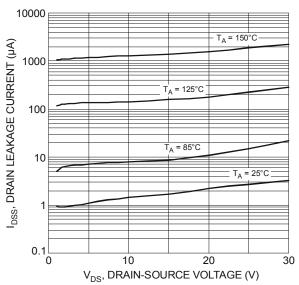
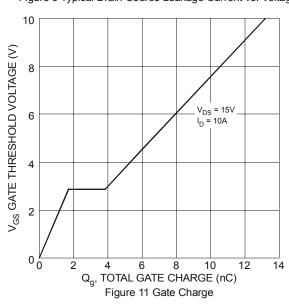
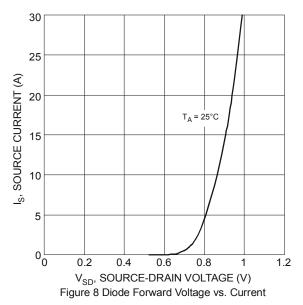
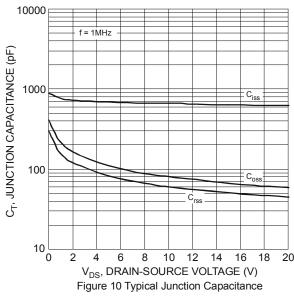
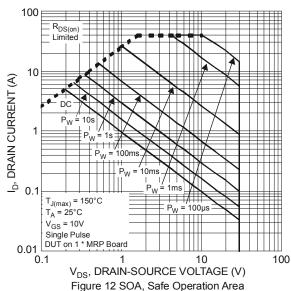


Figure 9 Typical Drain-Source Leakage Current vs. Voltage

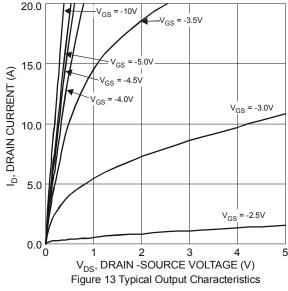


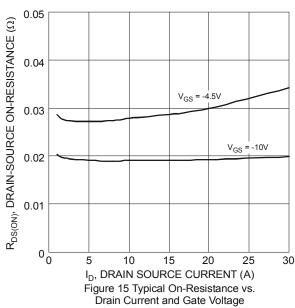












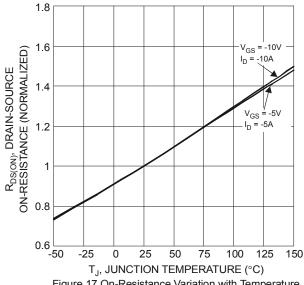
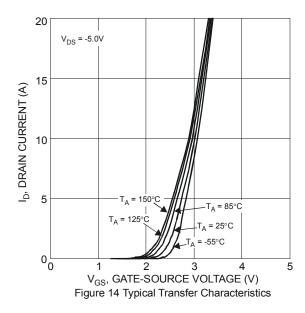
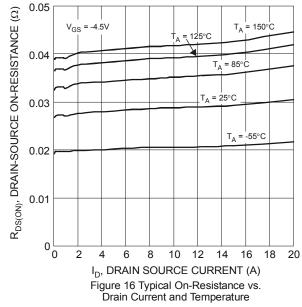


Figure 17 On-Resistance Variation with Temperature





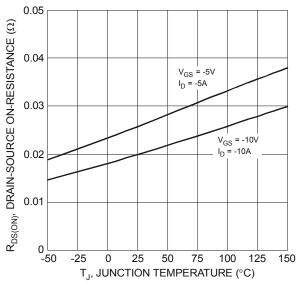


Figure 18 On-Resistance Variation with Temperature



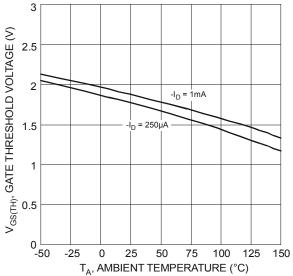


Figure 19 Gate Threshold Variation vs. Ambient Temperature

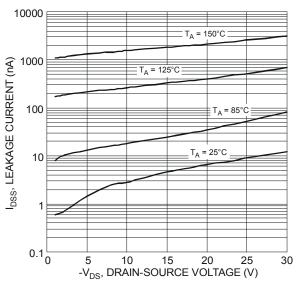
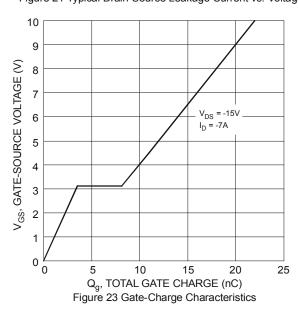
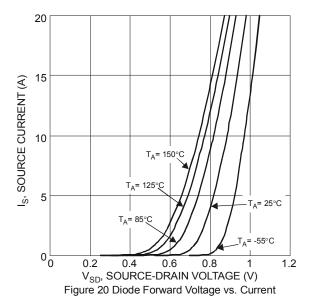
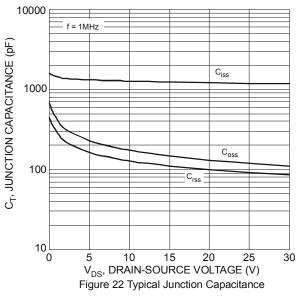
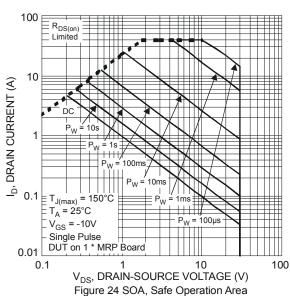


Figure 21 Typical Drain-Source Leakage Current vs. Voltage

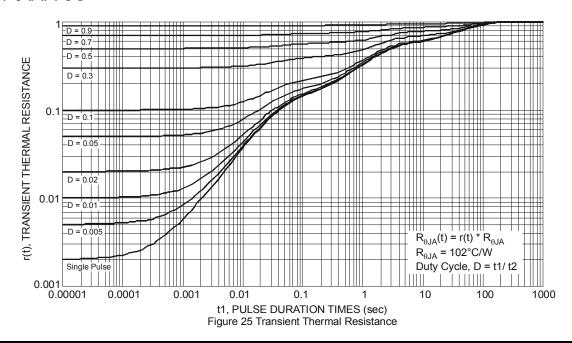






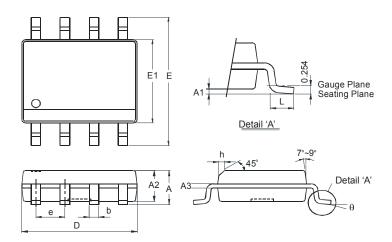






### **Package Outline Dimensions**

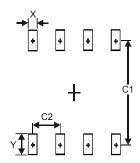
Please see AP02002 at http://www.diodes.com/datasheets/ap02002.pdf for latest version.



SO-8						
Dim	Min	Max				
Α	-	1.75				
A1	0.10	0.20				
A2	1.30	1.50				
A3	0.15	0.25				
b	0.3 0.5					
D	4.85	4.95				
Е	5.90	6.10				
E1	3.85 3.95					
е	<b>e</b> 1.27 Typ					
h	- 0.35					
L	0.62	0.82				
θ	0°	8°				
All Dimensions in mm						

# Suggested Pad Layout

Please see AP02001 at http://www.diodes.com/datasheets/ap02001.pdf for the latest version.



Dimensions	Value (in mm)
Х	0.60
Y	1.55
C1	5.4
C2	1.27



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